

#### Replaces DS5529-4

# DIM1800ESM12-A000

# Single Switch IGBT Module

DS5529-5 August 2014 (LN31871)

### **FEATURES**

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Non Punch Through Silicon
- Isolated AISiC Base with AIN Substrates
- Lead Free construction

# **APPLICATIONS**

- High Reliability Inverters
- Motor Controllers
- Traction Drives

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM1800ESM12-A000 is a single switch 1200V, n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

### **ORDERING INFORMATION**

Order As:

# DIM1800ESM12-A000

Note: When ordering, please use the complete part number

### **KEY PARAMETERS**

$V_{CES}$		1200V
V <sub>CE(sat)</sub>	* (typ)	2.2V
l <sub>c</sub> `́	(max)	1800A
I <sub>C(PK)</sub>	(max)	3600A

\* Measured at the power busbars, not the auxiliary terminals

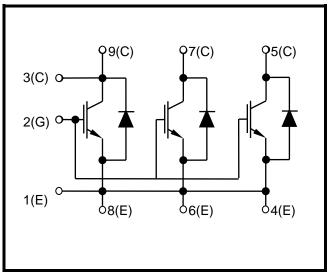


Fig. 1 Circuit configuration



### **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

### T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	$V_{GE} = 0V$	1200	V
V <sub>GES</sub>	Gate-emitter voltage		±20	V
Ι <sub>C</sub>	Continuous collector current	$T_{case} = 85^{\circ}C$	1800	А
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 115°C	3600	А
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_j = 150^{\circ}C$	15625	W
l <sup>2</sup> t	Diode I <sup>2</sup> t value	$V_R = 0, t_p = 10ms, T_j = 125^{o}C$	900	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2500	V
$Q_PD$	Partial discharge – per module	IEC1287, $V_1 = 1300V$ , $V_2 = 1000V$ , 50Hz RMS	10	рС

### THERMAL AND MECHANICAL RATINGS

Internal insulation material:	AIN
Baseplate material:	AISiC
Creepage distance:	33mm
Clearance:	20mm
CTI (Comparative Tracking Index):	>600

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	8	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode	Continuous dissipation - junction to case	-	-	13	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	6	°C/kW
Tj	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
$T_{stg}$	Storage temperature range	-	-40	-	125	°C
		Mounting – M6	-	-	5	Nm
	Screw torque	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

### **ELECTRICAL CHARACTERISTICS**

### T<sub>case</sub> = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
	0	$V_{GE} = 0V, V_{CE} = V_{CES}$			3	mA
I <sub>CES</sub>	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 125^{\circ}C$			75	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			12	μA
$V_{\text{GE(TH)}}$	Gate threshold voltage	$I_{C} = 90 \text{mA}, V_{GE} = V_{CE}$	4.5	5.5	6.5	V
M	Collector-emitter	V <sub>GE</sub> = 15V, I <sub>C</sub> = 1800A		2.2	2.8	V
V <sub>CE(sat)</sub>	saturation voltage	$V_{GE} = 15V, I_C = 1800A, T_j = 125^{\circ}C$		2.6	3.3	V
I <sub>F</sub>	Diode forward current	DC			1800	А
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms			3600	А
	V <sub>F</sub> Diode forward voltage	I <sub>F</sub> = 1800A		1.9	2.1	V
VF		I <sub>F</sub> = 1800A, T <sub>j</sub> = 125°C		1.8	2.1	V
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		200		nF
Qg	Gate charge	±15V		20		μC
C <sub>res</sub>	Reverse transfer capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz				nF
L <sub>M</sub>	Module inductance			10		nH
R <sub>INT</sub>	Internal transistor resistance			90		μΩ
SC <sub>Data</sub>	Short circuit current, I <sub>SC</sub>	$\begin{split} T_{j} &= 125^{\circ}C, \ V_{CC} = 900V \\ t_{p} &\leq 10\mu s, \ V_{GE} \leq 15V \\ V_{CE \ (max)} &= V_{CES} - L^{*} x \ dl/dt \\ IEC \ 60747-9 \end{split}$		10000		A

# Note:

L is the circuit inductance +  $L_M$ 

# **ELECTRICAL CHARACTERISTICS**

### T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
t <sub>d(off)</sub>	Turn-off delay time			1250		ns
t <sub>f</sub>	Fall time	$I_{\rm C} = 1800 \text{A}$ $V_{\rm GF} = \pm 15 \text{V}$		190		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{GE} = \pm 13V$ $V_{CE} = 600V$		330		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 1.2\Omega$		220		ns
t <sub>r</sub>	Rise time	$R_{G(OFF)} = 1.2\Omega$ $L_{S} \sim 60 \text{nH}$		200		ns
E <sub>ON</sub>	Turn-on energy loss			100		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 1800A		210		μC
l <sub>rr</sub>	Diode reverse recovery current	$V_{CE} = 600V$		860		А
E <sub>rec</sub>	Diode reverse recovery energy	dI <sub>F</sub> /dt = 9000A/µs		110		mJ

### T<sub>case</sub> = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
t <sub>d(off)</sub>	Turn-off delay time			1450		ns
t <sub>f</sub>	Fall time	$I_{C} = 1200A$ $V_{GF} = \pm 15V$		190		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = \pm 13V$ $V_{CE} = 600V$		390		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 1.2\Omega$		230		ns
t <sub>r</sub>	Rise time	$R_{G(OFF)} = 1.2\Omega$ $L_{S} \sim 60 \text{nH}$		340		ns
E <sub>ON</sub>	Turn-on energy loss			180		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 1800A		390		μC
I <sub>rr</sub>	Diode reverse recovery current	$V_{CE} = 600V$		1100		А
$E_{rec}$	Diode reverse recovery energy	dI <sub>F</sub> /dt = 8000A/µs		200		mJ

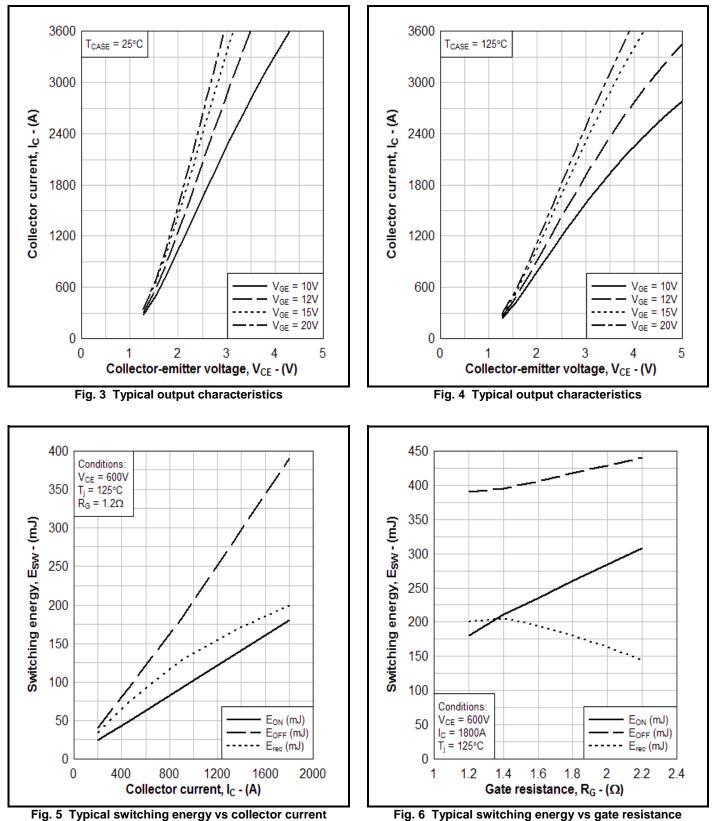
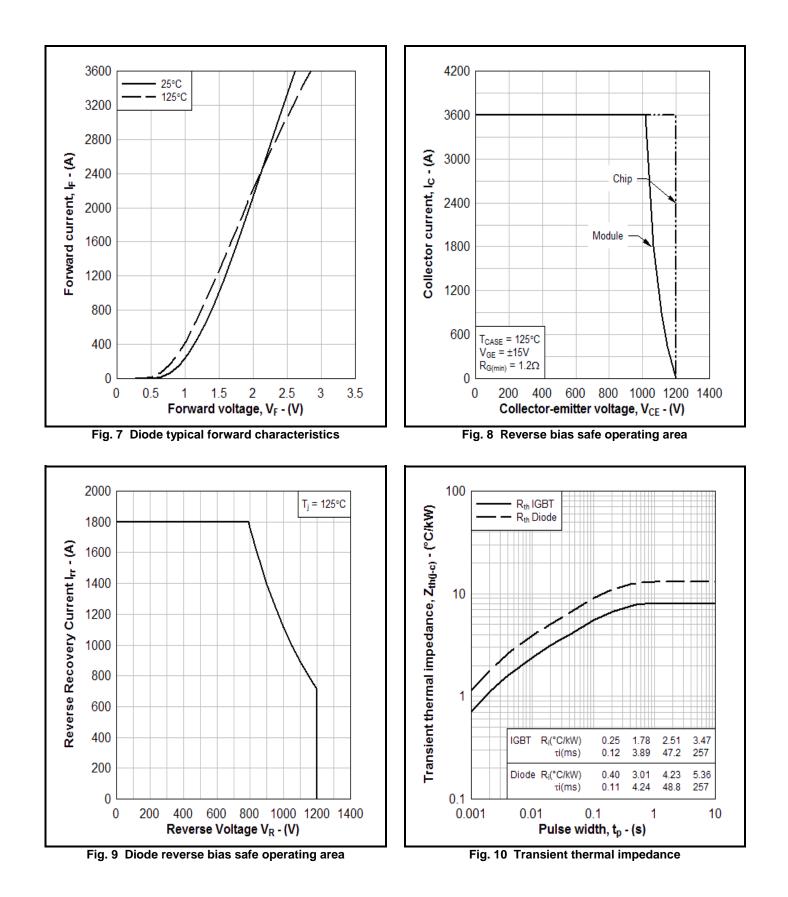
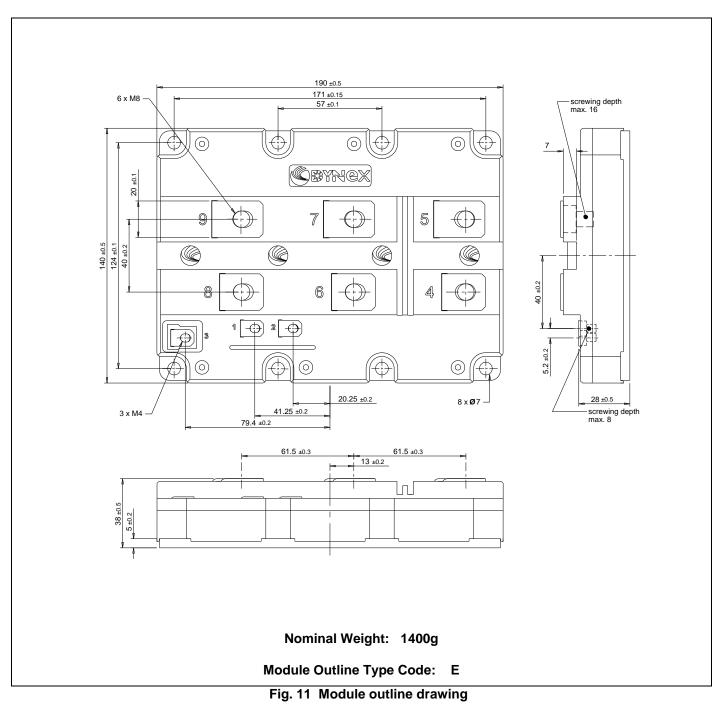


Fig. 6 Typical switching energy vs gate resistance



### PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. **DO NOT SCALE.** 



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